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	Document ID	Title	Current	Curren XRef	Inventor
2/ 1	US 2004007358 4 A1	Methods and apparatus for truncation compensation	708/200		Hsieh, Jiang e
1 2 2	US 2004006691 1 A1	Methods and apparatus for truncation compensation		378/210 ; 378/4	Hsieh, Jiang et al.
/ 3_	US 2004006690 9 A1	Multi modality imaging methods and apparatus	1/1		Lonn, Albert Henry Roger et al.
A .	US 2002017371 5 A1	Method for acquiring MRI data from a large field of view using continuous table motion	600/410		Kruger, David G. et al.
5	_18 A1	Charged particle beam apparatus	250/307		Kohama, Yoshiaki et al.
6	US 6718008 B1	X-ray diffraction screening system with retractable x-ray shield	378/71	378/206	He, Bob Baoping et al.
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8	[∤] RI	Micro lysis-analysis process to measure cell characteristics	435/29		Miller, Frederick N.
9/	US 5955295 A	Micro lysis-analysis process to measure cell characteristics and diagnose diseases	435/29	435/4; 435/7.2	Miller, Frederick N.
10	US 5638206 A	Confocal optical microscope and length measuring device using this microscope	359/368	359/371 ; 359/385 ; 359/388	Sumiya, Masato et al.
14	Α	Microphoto lysis-anlaysis process to measure cell characteristics	435/29	324/71. 1; 324/71. 4;	Miller, Frederick N.
12	US 5545992 A	Fast cardiac gated NMR acquisition with improved T.sub.1 contrast	324/309	ひいいりゅしつき	Foo, Thomas K.
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15	JS 4741621 G	Geometric surface inspection system with lual overlap light stripe generator	356/606 ;		aft, Jeffrey D. et al.

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16	US 4677297 A	Apparatus for obtaining an enlarged image of a portion of the field of view of an infra-red camera		250/332	Egerod, Eskel
1/	JP 11183139 A	SECTIONAL AND 3-DIMENSIONAL SHAPE MEASURING DEVICE			MOTEGI, TOSHIO et al.
1/8	JP 11183136 A	SECTIONAL AND 3-DIMENSIONAL SHAPE MEASURING DEVICE			MOTEGI, TOSHIO et al.